

**Notice of References Cited**

Application/Control No.

10/656,227

Applicant(s)/Patent Under

Reexamination

OGAWA, SOICHIRO

Examiner

Alix Elizabeth Echelmeyer

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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B	US-			
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D	US-			
E	US-			
F	US-			
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**FOREIGN PATENT DOCUMENTS**

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